Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
(barcode)	10/808,872	WANG ET AL.
	Examiner	Art Unit
	Patricia Leith	1655

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
ProQuest direct database (NPL)	7/12/2006	PL
EAST:JPO,EPO,DERWENT,USPATFULL,USPGPUBS,OCRBACKFILE	7/21/2006	PL
Inventor name search PALM/EAST	7/21/2006	PL